Application/Control No. Applicant(s)/Patent Under Reexamination 10/627,780 FAN, KEJUN Notice of References Cited Art Unit Examiner Page 1 of 1 1637 Young J. Kim **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY WO DZIEGLEWSKA et al. C07H 1/08 WO 98/51693-A1 11-1998 Ν EP EZEKE et al. G01N 33/50 EP 0 795 751 A2 09-1997 0 Р 5-30-06 Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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